


<b>Search Notes</b> 	<b>Application/Control No.</b> 09940035	<b>Applicant(s)/Patent Under Reexamination</b> LEE ET AL.
	<b>Examiner</b> MINH DINH	<b>Art Unit</b> 2132

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
713/165,167-171,185; 726/26-27,29-30; 705/51,57-58; 380/201-202,278-279,281-285 (text search only for all - see search history printout)	3/15/08	MD
EAST (US-PGPUB, USPAT, EPO, JPO, DERWENT, IBM_TDB) - see search history printout	3/15/08	MD
NPL (IEEE, GOOGLE)	3/15/08	MD
Inventor Name Search	3/16/08	MD

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner